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Understanding Embedded - DSP (Digital Signal Processors)

Embedded - DSP (Digital Signal Processors) are specialized microprocessors designed to perform complex mathematical computations on digital signals in real-time. Unlike general-purpose processors, DSPs are optimized for high-speed numeric processing tasks, making them ideal for applications that require efficient and precise manipulation of digital data. These processors are fundamental in converting and processing signals in various forms, including audio, video, and communication signals, ensuring that data is accurately interpreted and utilized in embedded systems.

Applications of <u>Embedded - DSP (Digital Signal Processors)</u>

Details	
Product Status	Active
Туре	Blackfin+
nterface	CAN, DSPI, EBI/EMI, I²C, PPI, QSPI, SD/SDIO, SPI, SPORT, UART/USART, USB OTG
Clock Rate	400MHz
Non-Volatile Memory	ROM (512kB)
On-Chip RAM	512kB
/oltage - I/O	1.8V, 3.3V
/oltage - Core	1.10V
perating Temperature	-40°C ~ 85°C (TA)
lounting Type	Surface Mount
Package / Case	88-VFQFN Exposed Pad, CSP
Supplier Device Package	88-LFCSP-VQ (12x12)
Purchase URL	https://www.e-xfl.com/product-detail/analog-devices/adsp-bf704bcpz-4

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

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Table 3. Clock Dividers

	Divider (if Available on
Clock Source	SYS_CLKOUT)
CCLK (Core Clock)	By 16
SYSCLK (System Clock)	By 8
SCLK0 (System Clock, All Peripherals not Covered by SCLK1)	Not available on SYS_CLKOUT
SCLK1 (System Clock for Crypto Engines and MDMA)	By 8
DCLK (LPDDR/DDR2 Clock)	By 8
OCLK (Output Clock)	Programmable
CLKBUF	None, direct from SYS_CLKIN

Power Management

As shown in Table 4, the processor supports multiple power domains, which maximizes flexibility while maintaining compliance with industry standards and conventions. There are no sequencing requirements for the various power domains, but all domains must be powered according to the appropriate Specifications table for processor operating conditions; even if the feature/peripheral is not used.

Table 4. Power Domains

Power Domain	V _{DD} Range
All Internal Logic	V_{DD_INT}
DDR2/LPDDR	V_{DD_DMC}
USB	V_{DD_USB}
OTP Memory	V_{DD_OTP}
HADC	V_{DD_HADC}
RTC	V_{DD_RTC}
All Other I/O (Includes SYS, JTAG, and Ports Pins)	V_{DD_EXT}

The dynamic power management feature of the processor allows the processor's core clock frequency (f_{CCLK}) to be dynamically controlled.

The power dissipated by a processor is largely a function of its clock frequency and the square of the operating voltage. For example, reducing the clock frequency by 25% results in a 25% reduction in dynamic power dissipation.

See Table 5 for a summary of the power settings for each mode.

Full-On Operating Mode—Maximum Performance

In the full-on mode, the PLL is enabled and is not bypassed, providing capability for maximum operational frequency. This is the power-up default execution state in which maximum performance can be achieved. The processor core and all enabled peripherals run at full speed.

Deep Sleep Operating Mode—Maximum Dynamic Power Savings

The deep sleep mode maximizes dynamic power savings by disabling the clocks to the processor core and to all synchronous peripherals. Asynchronous peripherals may still be running but cannot access internal resources or external memory.

Table 5. Power Settings

Mode/State	PII	PLL Bypassed		f _{SYSCLK} , f _{DCLK} , f _{SCLK0} , f _{SCLK1}	Core Power
Full On	Enabled	No	Enabled		On
Deep Sleep	Disabled	_	Disabled	Disabled	On
Hibernate	Disabled	_	Disabled	Disabled	Off

Hibernate State—Maximum Static Power Savings

The hibernate state maximizes static power savings by disabling the voltage and clocks to the processor core and to all of the peripherals. This setting signals the external voltage regulator supplying the VDD_INT pins to shut off using the SYS_EXTWAKE signal, which provides the lowest static power dissipation.

Any critical information stored internally (for example, memory contents, register contents, and other information) must be written to a nonvolatile storage device (or self-refreshed DRAM) prior to removing power if the processor state is to be preserved.

Because the V_{DD_EXT} pins can still be supplied in this mode, all of the external pins three-state, unless otherwise specified. This allows other devices that may be connected to the processor to still have power applied without drawing unwanted current.

Reset Control Unit

Reset is the initial state of the whole processor or the core and is the result of a hardware- or software-triggered event. In this state, all control registers are set to their default values and functional units are idle. Exiting a full system reset starts with the core being ready to boot.

The reset control unit (RCU) controls how all the functional units enter and exit reset. Differences in functional requirements and clocking constraints define how reset signals are generated. Programs must guarantee that none of the reset functions puts the system into an undefined state or causes resources to stall. This is particularly important when the core is reset (programs must ensure that there is no pending system activity involving the core when it is being reset).

From a system perspective, reset is defined by both the reset target and the reset source described as follows in the following list.

Target defined:

- Hardware Reset—All functional units are set to their default states without exception. History is lost.
- System Reset—All functional units except the RCU are set to their default states.
- Core-only Reset—Affects the core only. The system software should guarantee that the core, while in reset state, is not accessed by any bus master.

Source defined:

- Hardware Reset—The SYS_HWRST input signal is asserted active (pulled down).
- System Reset—May be triggered by software (writing to the RCU_CTL register) or by another functional unit such as the dynamic power management (DPM) unit (hibernate) or any of the system event controller (SEC), trigger routing unit (TRU), or emulator inputs.
- Core-only Reset—Triggered by software.
- Trigger request (peripheral).

Voltage Regulation

The processor requires an external voltage regulator to power the VDD_INT pins. To reduce standby power consumption, the external voltage regulator can be signaled through SYS_EXTWAKE to remove power from the processor core. This signal is high-true for power-up and may be connected directly to the low-true shut-down input of many common regulators.

While in the hibernate state, all external supply pins (VDD_EXT, VDD_USB, and VDD_DMC) can still be powered, eliminating the need for external buffers. The external voltage regulator can be activated from this power down state by asserting the \$\overline{SYS}_HWRST\$ pin, which then initiates a boot sequence. \$\overline{SYS}_EXTWAKE\$ indicates a wake-up to the external voltage regulator.

SYSTEM DEBUG

The processor includes various features that allow for easy system debug. These are described in the following sections.

System Watchpoint Unit

The system watchpoint unit (SWU) is a single module which connects to a single system bus and provides for transaction monitoring. One SWU is attached to the bus going to each system slave. The SWU provides ports for all system bus address channel signals. Each SWU contains four match groups of registers with associated hardware. These four SWU match groups operate independently, but share common event (interrupt, trigger, and others) outputs.

Debug Access Port

The debug access port (DAP) provides IEEE-1149.1 JTAG interface support through its JTAG debug and serial wire debug port (SWJ-DP). SWJ-DP is a combined JTAG-DP and SW-DP that enables either serial wire debug (SWD) or a JTAG emulator to be connected to a target. SWD signals share the same pins as

JTAG. The DAP provides an optional instrumentation trace for both the core and system. It provides a trace stream that conforms to MIPI System Trace Protocol version 2 (STPv2).

DEVELOPMENT TOOLS

Analog Devices supports its processors with a complete line of software and hardware development tools, including integrated development environments (CrossCore® Embedded Studio), evaluation products, emulators, and a wide variety of software add-ins

Integrated Development Environments (IDEs)

CrossCore Embedded Studio is based on the Eclipse™ framework. Supporting most Analog Devices processor families, it is the IDE of choice for future processors, including multicore devices. CrossCore Embedded Studio seamlessly integrates available software add-ins to support real time operating systems, file systems, TCP/IP stacks, USB stacks, algorithmic software modules, and evaluation hardware board support packages. For more information, visit www.analog.com/cces.

EZ-KIT Lite Evaluation Board

For processor evaluation, Analog Devices provides a wide range of EZ-KIT Lite[®] evaluation boards. Including the processor and key peripherals, the evaluation board also supports on-chip emulation capabilities and other evaluation and development features. Also available are various EZ-Extenders[®], which are daughter cards delivering additional specialized functionality, including audio and video processing. For more information, visit www.analog.com and search on "ezkit" or "ezextender".

EZ-KIT Lite Evaluation Kits

For a cost-effective way to learn more about developing with Analog Devices processors, Analog Devices offer a range of EZ-KIT Lite evaluation kits. Each evaluation kit includes an EZ-KIT Lite evaluation board, directions for downloading an evaluation version of the available IDE, a USB cable, and a power supply. The USB controller on the EZ-KIT Lite board connects to the USB port of the user's PC, enabling the chosen IDE evaluation suite to emulate the on-board processor in-circuit. This permits the customer to download, execute, and debug programs for the EZ-KIT Lite system. It also supports in-circuit programming of the on-board Flash device to store user-specific boot code, enabling standalone operation. With the full version of Cross-Core Embedded Studio installed (sold separately), engineers can develop software for supported EZ-KITs or any custom system utilizing supported Analog Devices processors.

ADSP-BF706 EZ-KIT Mini

The ADSP-BF706 EZ-KIT Mini™ product (ADZS-BF706-EZMini) contains the ADSP-BF706 processor and is shipped with all of the necessary hardware. Users can start their evaluation immediately. The EZ-KIT Mini product includes the standalone evaluation board and USB cable. The EZ-KIT Mini ships with an on-board debug agent.

The evaluation board is designed to be used in conjunction with the CrossCore Embedded Studio (CCES) development tools to test capabilities of the ADSP-BF706 Blackfin processor.

Blackfin Low Power Imaging Platform (BLIP)

The Blackfin low power imaging platform (BLIP) integrates the ADSP-BF707 Blackfin processor and Analog Devices software code libraries. The code libraries are optimized to detect the presence and behavior of humans or vehicles in indoor and outdoor environments. The BLIP hardware platform is delivered preloaded with the occupancy software module.

Software Add-Ins for CrossCore Embedded Studio

Analog Devices offers software add-ins which seamlessly integrate with CrossCore Embedded Studio to extend its capabilities and reduce development time. Add-ins include board support packages for evaluation hardware, various middleware packages, and algorithmic modules. Documentation, help, configuration dialogs, and coding examples present in these add-ins are viewable through the CrossCore Embedded Studio IDE once the add-in is installed.

Board Support Packages for Evaluation Hardware

Software support for the EZ-KIT Lite evaluation boards and EZ-Extender daughter cards is provided by software add-ins called board support packages (BSPs). The BSPs contain the required drivers, pertinent release notes, and select example code for the given evaluation hardware. A download link for a specific BSP is located on the web page for the associated EZ-KIT or EZ-Extender product. The link is found in the *Product Download* area of the product web page.

Middleware Packages

Analog Devices separately offers middleware add-ins such as real time operating systems, file systems, USB stacks, and TCP/IP stacks. For more information, see the following web pages:

- www.analog.com/ucos3
- www.analog.com/ucfs
- www.analog.com/ucusbd
- www.analog.com/lwip

Algorithmic Modules

To speed development, Analog Devices offers add-ins that perform popular audio and video processing algorithms. These are available for use with CrossCore Embedded Studio. For more information, visit www.analog.com and search on "Blackfin software modules" or "SHARC software modules".

Designing an Emulator-Compatible DSP Board (Target)

For embedded system test and debug, Analog Devices provides a family of emulators. On each DAP-enabled processor, Analog Devices supplies an IEEE 1149.1 JTAG test access port (TAP), serial wire debug port (SWJ-DP), and trace capabilities. In-circuit emulation is facilitated by use of the JTAG or SWD interface. The emulator accesses the processor's internal features through the processor's TAP, allowing the developer to load code, set breakpoints, and view variables, memory, and

registers. The emulators require the target board to include a header(s) that supports connection of the processor's DAP to the emulator for trace and debug.

Analog Devices emulators actively drive JTG_TRST high. Third-party emulators may expect a pull-up on JTG_TRST and therefore will not drive JTG_TRST high. When using this type of third-party emulator JTG_TRST must still be driven low during power-up reset, but should subsequently be driven high externally before any emulation or boundary-scan operations. See Power-Up Reset Timing on Page 61 for more information on POR specifications.

For more details on target board design issues including mechanical layout, single processor connections, signal buffering, signal termination, and emulator pod logic, contact the factory for more information.

ADDITIONAL INFORMATION

The following publications that describe the ADSP-BF70x processors can be accessed electronically on our website:

- ADSP-BF70x Blackfin+ Processor Hardware Reference
- ADSP-BF70x Blackfin+ Processor Programming Reference
- ADSP-BF70x Blackfin+ Processor Anomaly List

RELATED SIGNAL CHAINS

A signal chain is a series of signal-conditioning electronic components that receive input (data acquired from sampling either real-time phenomena or from stored data) in tandem, with the output of one portion of the chain supplying input to the next. Signal chains are often used in signal processing applications to gather and process data or to apply system controls based on analysis of real-time phenomena.

Analog Devices eases signal processing system development by providing signal processing components that are designed to work together well. A tool for viewing relationships between specific applications and related components is available on the www.analog.com website.

The application signal chains page in the Circuits from the Lab[®] site (http:\\www.analog.com\circuits) provides:

- Graphical circuit block diagram presentation of signal chains for a variety of circuit types and applications
- Drill down links for components in each chain to selection guides and application information
- Reference designs applying best practice design techniques

Table 7. ADSP-BF70x 184-Ball CSP_BGA Signal Descriptions (Continued)

Signal Name	Description	Port	Pin Name
SMC0_ARE	SMC0 Read Enable	A	PA_13
SMC0_AWE	SMC0 Write Enable	Α	PA_14
SMC0_D00	SMC0 Data 0	В	PB_07
SMC0_D01	SMC0 Data 1	В	PB_06
SMC0_D02	SMC0 Data 2	В	PB_05
SMC0_D03	SMC0 Data 3	В	PB_04
SMC0_D04	SMC0 Data 4	В	PB_03
SMC0_D05	SMC0 Data 5	В	PB_02
SMC0_D06	SMC0 Data 6	В	PB_01
SMC0_D07	SMC0 Data 7	В	PB_00
SMC0_D08	SMC0 Data 8	В	PB_08
SMC0_D09	SMC0 Data 9	В	PB_09
SMC0_D10	SMC0 Data 10	В	PB_10
SMC0_D11	SMC0 Data 11	В	PB_11
SMC0_D12	SMC0 Data 12	В	PB_12
SMC0_D13	SMC0 Data 13	В	PB_13
SMC0_D14	SMC0 Data 14	В	PB_14
SMC0_D15	SMC0 Data 15	В	PB_15
SPIO_CLK	SPI0 Clock	В	PB_00
SPIO_CLK	SPI0 Clock	C	PC_04
SPIO_D2	SPI0 Data 2	В	PB_03
SPIO_D2	SPI0 Data 2	C	PC_08
SPIO_D2	SPI0 Data 3	В	PB_07
	SPI0 Data 3	C	PC_09
SPI0_D3 SPI0_MISO	SPIO Master In, Slave Out	В	PB_01
	SPI0 Master In, Slave Out	C	PC_06
SPIO_MISO	SPIO Master Out, Slave In		
SPIO_MOSI		В	PB_02
SPIO_MOSI	SPIO Master Out, Slave In SPIO Ready	C	PC_07
SPIO_RDY		A	PA_06
SPIO_SEL1	SPI0 Slave Select Output 1	A	PA_05
SPIO_SEL2	SPI0 Slave Select Output 2	A	PA_06
SPIO_SEL3	SPI0 Slave Select Output 3	C	PC_11
SPIO_SEL4	SPI0 Slave Select Output 4	В	PB_04
SPIO_SEL5	SPI0 Slave Select Output 5	В	PB_05
SPIO_SEL6	SPI0 Slave Select Output 6	В	PB_06
SPIO_SS	SPIO Slave Select Input	A	PA_05
SPI1_CLK	SPI1 Clock	A	PA_00
SPI1_MISO	SPI1 Master In, Slave Out	A	PA_01
SPI1_MOSI	SPI1 Master Out, Slave In	A	PA_02
SPI1_RDY	SPI1 Ready	A	PA_03
SPI1_SEL1	SPI1 Slave Select Output 1	A	PA_04
SPI1_SEL2	SPI1 Slave Select Output 2	A	PA_03
SPI1_SEL3	SPI1 Slave Select Output 3	C	PC_10
SPI1_SEL4	SPI1 Slave Select Output 4	Α	PA_14
SPI1_SS	SPI1 Slave Select Input	Α	PA_04
SPI2_CLK	SPI2 Clock	В	PB_10

12 mm × 12 mm 88-LEAD LFCSP (QFN) SIGNAL DESCRIPTIONS

The processor's pin definitions are shown in Table 11. The columns in this table provide the following information:

- Signal Name: The Signal Name column in the table includes the signal name for every pin and (where applicable) the GPIO multiplexed pin function for every pin.
- Description: The Description column in the table provides a verbose (descriptive) name for the signal.
- General-Purpose Port: The Port column in the table shows whether or not the signal is multiplexed with other signals on a general-purpose I/O port pin.
- Pin Name: The Pin Name column in the table identifies the name of the package pin (at power on reset) on which the signal is located (if a single function pin) or is multiplexed (if a general-purpose I/O pin).

Table 11. ADSP-BF70x 12 mm × 12 mm 88-Lead LFCSP (QFN) Signal Descriptions

Signal Name	Description	Port	Pin Name
CAN0_RX	CAN0 Receive	С	PC_02
CAN0_TX	CAN0 Transmit	C	PC_03
CAN1_RX	CAN1 Receive	A	PA_12
CAN1_TX	CAN1 Transmit	A	PA_13
CNT0_DG	CNT0 Count Down and Gate	A	PA_07
CNT0_UD	CNT0 Count Up and Direction	A	PA_15
CNT0_ZM	CNT0 Count Zero Marker	A	PA_13
GND	Ground	Not Muxed	GND
JTG_SWCLK	TAPC0 Serial Wire Clock	Not Muxed	JTG_TCK_SWCLK
JTG_SWDIO	TAPC0 Serial Wire DIO	Not Muxed	JTG_TMS_SWDIO
JTG_SWO	TAPC0 Serial Wire Out	Not Muxed	JTG_TDO_SWO
JTG_TCK	TAPC0 JTAG Clock	Not Muxed	JTG_TCK_SWCLK
JTG_TDI	TAPC0 JTAG Serial Data In	Not Muxed	JTG_TDI
JTG_TDO	TAPC0 JTAG Serial Data Out	Not Muxed	JTG_TDO_SWO
JTG_TMS	TAPC0 JTAG Mode Select	Not Muxed	JTG_TMS_SWDIO
JTG_TRST	TAPC0 JTAG Reset	Not Muxed	JTG_TRST
MSI0_CD	MSI0 Card Detect	A	PA_08
MSI0_CLK	MSI0 Clock	C	PC_09
MSI0_CMD	MSI0 Command	C	PC_05
MSI0_D0	MSI0 Data 0	C	PC_08
MSI0_D1	MSI0 Data 1	C	PC_04
MSI0_D2	MSI0 Data 2	С	PC_07
MSI0_D3	MSI0 Data 3	c	PC_06
MSI0_D4	MSI0 Data 4	C	PC_10
PA_00-PA_15	Position 00 through Position 15	A	PA_00-PA_15
PB_00-PB_15	Position 00 through Position 15	В	PB_00-PB_15
PC_00-PC_10	Position 00 through Position 10	c	PC_00-PC_10
PPI0_CLK	EPPI0 Clock	A	PA_14
PPI0_D00	EPPI0 Data 0	В	PB_07
PPI0_D01	EPPI0 Data 1	В	PB_06
PPI0_D02	EPPI0 Data 2	В	PB_05
PPI0_D03	EPPI0 Data 3	В	PB_04
PPI0_D04	EPPI0 Data 4	В	PB_03
PPI0_D05	EPPI0 Data 5	В	PB_02
PPI0_D06	EPPI0 Data 6	В	PB_01
PPI0_D07	EPPI0 Data 7	В	PB_00

Table 11. ADSP-BF70x 12 mm \times 12 mm 88-Lead LFCSP (QFN) Signal Descriptions (Continued)

Signal Name	Description	Port	Pin Name
SPTO_AFS	SPORTO Channel A Frame Sync	A	PA_12
SPTO_AFS	SPORTO Channel A Frame Sync	С	PC_05
SPT0_ATDV	SPORTO Channel A Transmit Data Valid	Α	PA_15
SPT0_BCLK	SPORTO Channel B Clock	В	PB_04
SPT0_BCLK	SPORTO Channel B Clock	С	PC_04
SPT0_BD0	SPORTO Channel B Data 0	В	PB_05
SPT0_BD0	SPORT0 Channel B Data 0	С	PC_06
SPT0_BD1	SPORT0 Channel B Data 1	В	PB_07
SPT0_BD1	SPORT0 Channel B Data 1	С	PC_01
SPTO_BFS	SPORTO Channel B Frame Sync	В	PB_06
SPTO_BFS	SPORTO Channel B Frame Sync	C	PC_07
SPT0_BTDV	SPORTO Channel B Transmit Data Valid	A	PA_15
SPT1_ACLK	SPORT1 Channel A Clock	A	PA_08
SPT1_AD0	SPORT1 Channel A Data 0	Α	PA_10
SPT1_AD1	SPORT1 Channel A Data 1	Α	PA_11
SPT1_AFS	SPORT1 Channel A Frame Sync	Α	PA_09
SPT1_ATDV	SPORT1 Channel A Transmit Data Valid	Α	PA_07
SPT1_BCLK	SPORT1 Channel B Clock	В	PB_00
SPT1_BCLK	SPORT1 Channel B Clock	C	PC_10
SPT1_BD0	SPORT1 Channel B Data 0	В	PB_02
SPT1_BD1	SPORT1 Channel B Data 1	В	PB_03
SPT1_BFS	SPORT1 Channel B Frame Sync	В	PB_01
SPT1_BTDV	SPORT1 Channel B Transmit Data Valid	Α	PA_07
SYS_BMODE0	Boot Mode Control 0	Not Muxed	SYS_BMODE0
SYS_BMODE1	Boot Mode Control 1	Not Muxed	SYS_BMODE1
SYS_CLKIN	Clock/Crystal Input	Not Muxed	SYS_CLKIN
SYS_CLKOUT	Processor Clock Output	Not Muxed	SYS_CLKOUT
SYS_EXTWAKE	External Wake Control	Not Muxed	SYS_EXTWAKE
SYS_FAULT	Active-Low Fault Output	Not Muxed	SYS_FAULT
SYS_HWRST	Processor Hardware Reset Control	Not Muxed	SYS_HWRST
SYS_NMI	Non-maskable Interrupt	Not Muxed	SYS_NMI
SYS_RESOUT	Reset Output	Not Muxed	SYS_RESOUT
SYS_WAKE0	Power Saving Mode Wake-up 0	В	PB_07
SYS_WAKE1	Power Saving Mode Wake-up 1	В	PB_08
SYS_WAKE2	Power Saving Mode Wake-up 2	В	PB_12
SYS_WAKE3	Power Saving Mode Wake-up 3	С	PC_02
SYS_WAKE4	Power Saving Mode Wake-up 4	Α	PA_12
SYS_XTAL	Crystal Output	Not Muxed	SYS_XTAL
TM0_ACI0	TIMER0 Alternate Capture Input 0	С	PC_03
TM0_ACI1	TIMERO Alternate Capture Input 1	В	PB_01
TM0_ACI2	TIMERO Alternate Capture Input 2	С	PC_07
TM0_ACI3	TIMERO Alternate Capture Input 3	В	PB_09
TM0_ACI4	TIMERO Alternate Capture Input 4	С	PC_01
TM0_ACI5	TIMERO Alternate Capture Input 5	С	PC_02
TM0_ACI6	TIMERO Alternate Capture Input 6	A	PA_12
TM0_ACLK0	TIMERO Alternate Clock 0	C	PC_04

Table 15. ADSP-BF70x Designer Quick Reference (Continued)

		Driver	Int	Reset	Reset	Hiber	Hiber	Power	Description
Signal Name	Туре	Туре	Term	Term	Drive	Term	Drive	Domain	and Notes
GND_HADC	g	na	none	none	none	none	none	na	Desc: Ground HADC Notes: If HADC is not used, connect to ground.
HADC0_VIN0	a	na	none	none	none	none	none	VDD_HADC	Desc: HADC0 Analog Input at channel 0 Notes: If HADC is not used, connect to ground.
HADC0_VIN1	a	na	none	none	none	none	none	VDD_HADC	Desc: HADC0 Analog Input at channel 1 Notes: If HADC is not used, connect to ground.
HADC0_VIN2	a	na	none	none	none	none	none	VDD_HADC	Desc: HADC0 Analog Input at channel 2 Notes: If HADC is not used, connect to ground.
HADC0_VIN3	a	na	none	none	none	none	none	VDD_HADC	Desc: HADC0 Analog Input at channel 3 Notes: If HADC is not used, connect to ground.
HADC0_VREFN	a	na	none	none	none	none	none	VDD_HADC	Desc: HADC0 Ground Reference for ADC Notes: If HADC is not used, connect to
HADC0_VREFP	a	na	none	none	none	none	none	VDD_HADC	ground. Desc: HADC0 External Reference for ADC Notes: If HADC is not used, connect to ground.
JTG_TCK_ SWCLK	I/O	na	pd	none	none	none	none	VDD_EXT	Desc: JTAG Clock Serial Wire Clock Notes: Functional during reset.
JTG_TDI	I/O	na	pu	none	none	none	none	VDD_EXT	Desc: JTAG Serial Data In Notes: Functional during reset.
JTG_TDO_SWO	I/O	A	none	none	none	none	none	VDD_EXT	Desc: JTAG Serial Data Out Serial Wire Out Notes: Functional during reset, three-
JTG_TMS_ SWDIO	I/O	A	pu	none	none	none	none	VDD_EXT	state when JTG_TRST is asserted. Desc: JTAG Mode Select Serial Wire DIO Notes: Functional during reset.
JTG_TRST	I/O	na	pd	none	none	none	none	VDD_EXT	Desc: JTAG Reset Notes: Functional during reset, a 10k external pull-down may be used to shorten the t _{VDDEXT_RST} timing requirement.
PA_00	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPI1 Clock TRACE0 Trace Data 7 SMC0 Byte Enable 0 Notes: SPI clock requires a pull-down when controlling most SPI flash devices.
PA_01	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPI1 Master In, Slave Out TRACE0 Trace Data 6 SMC0 Byte Enable 1 Notes: Pull-up required for SPI_MISO if SPI master boot is used.

Table 15. ADSP-BF70x Designer Quick Reference (Continued)

Signal Name	Туре	Driver Type	Int Term	Reset Term	Reset Drive	Hiber Term	Hiber Drive	Power Domain	Description and Notes
PC_05	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPT0 Channel A Frame Sync TM0 Timer 3 MSI0 Command Notes: An external pull-up may be required for MSI modes, see the MSI chapter in the hardware reference for details.
PC_06	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPT0 Channel B Data 0 SPI0 Master In, Slave Out MSI0 Data 3 Notes: An external pull-up may be required for MSI modes, see the MSI chapter in the hardware reference for details.
PC_07	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPT0 Channel B Frame Sync SPI0 Master Out, Slave In MSI0 Data 2 TM0 Alternate Capture Input 2 Notes: An external pull-up may be required for MSI modes, see the MSI chapter in the hardware reference for details.
PC_08	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPT0 Channel A Data 0 SPI0 Data 2 MSI0 Data 0 Notes: An external pull-up may be required for MSI modes, see the MSI chapter in the hardware reference for details.
PC_09	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPT0 Channel A Clock SPI0 Data 3 MSI0 Clock TM0 Alternate Clock 2 Notes: No notes.
PC_10	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPT1 Channel B Clock MSI0 Data 4 SPI1 Slave Select Output 3 TM0 Alternate Clock 1 Notes: An external pull-up may be required for MSI modes, see the MSI chapter in the hardware reference for details. SPI slave select outputs require a pull-up when used.
PC_11	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPT1 Channel B Frame Sync MSI0 Data 5 SPI0 Slave Select Output 3 Notes: An external pull-up may be required for MSI modes, see the MSI chapter in the hardware reference for details. SPI slave select outputs require a pull-up when used.
PC_12	I/O	A	none	none	none	none	none	VDD_EXT	Desc: SPT1 Channel B Data 0 MSI0 Data 6 Notes: An external pull-up may be required for MSI modes, see the MSI chapter in the hardware reference for details.

Table 18. Peripheral Clock Operating Conditions

Parameter		Restriction	Min	Тур	Max	Unit
f _{OCLK}	Output Clock Frequency				50	MHz
$f_{\text{SYS_CLKOUTJ}}$	SYS_CLKOUT Period Jitter ^{1, 2}			±2		%
f_{PCLKPROG}	Programmed PPI Clock When Transmitting Data and Frame Sync				50	MHz
$f_{PCLKPROG}$	Programmed PPI Clock When Receiving Data or Frame Sync				50	MHz
f_{PCLKEXT}	External PPI Clock When Receiving Data and Frame Sync ^{3, 4}	$f_{PCLKEXT} \le f_{SCLK0}$			50	MHz
f_{PCLKEXT}	External PPI Clock Transmitting Data or Frame Sync ^{3, 4}	$f_{PCLKEXT} \le f_{SCLK0}$			50	MHz
$f_{\text{SPTCLKPROG}}$	Programmed SPT Clock When Transmitting Data and Frame Sync				50	MHz
$f_{\text{SPTCLKPROG}}$	Programmed SPT Clock When Receiving Data or Frame Sync				50	MHz
$f_{\text{SPTCLKEXT}}$	External SPT Clock When Receiving Data and Frame Sync ^{3, 4}	$f_{SPTCLKEXT} \leq f_{SCLK0}$			50	MHz
$f_{\text{SPTCLKEXT}}$	External SPT Clock Transmitting Data or Frame Sync ^{3, 4}	$f_{SPTCLKEXT} \le f_{SCLK0}$			50	MHz
$f_{\text{SPICLKPROG}}$	Programmed SPI Clock When Transmitting Data				50	MHz
$f_{SPICLKPROG}$	Programmed SPI Clock When Receiving Data				50	MHz
$f_{SPICLKEXT}$	External SPI Clock When Receiving Data ^{3, 4}	$f_{SPICLKEXT} \leq f_{SCLK0}$			50	MHz
$f_{\text{SPICLKEXT}}$	External SPI Clock When Transmitting Data ^{3, 4}	$f_{SPICLKEXT} \leq f_{SCLK0}$			50	MHz
$f_{MSICLKPROG}$	Programmed MSI Clock				50	MHz

¹ SYS_CLKOUT jitter is dependent on the application system design including pin switching activity, board layout, and the jitter characteristics of the SYS_CLKIN source. Due to the dependency on these factors the measured jitter may be higher or lower than this typical specification for each end application.

⁴The peripheral external clock frequency must also be less than or equal to the f_{SCLK} that clocks the peripheral.

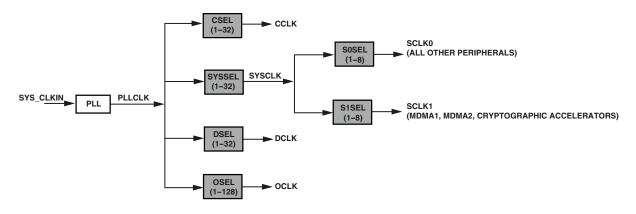


Figure 6. Clock Relationships and Divider Values

Table 19. Phase-Locked Loop Operating Conditions

Parameter		Min	Max	Unit
f _{PLLCLK}	PLL Clock Frequency	230.2	800	MHz
CGU_CTL.MSEL ¹	PLL Multiplier	8	41	

 $^{^1}$ The CGU_CTL.MSEL setting must also be chosen to ensure that the f_{PLLCLK} specification is not violated.

² The value in the Typ field is the percentage of the SYS_CLKOUT period.

³ The maximum achievable frequency for any peripheral in external clock mode is dependent on being able to meet the setup and hold times in the ac timing specifications section for that peripheral. Pay particular attention to setup and hold times for VDD_EXT = 1.8 V which may preclude the maximum frequency listed here.

PACKAGE INFORMATION

The information presented in Figure 7 and Table 27 provides details about package branding. For a complete listing of product availability, see the Ordering Guide.



Figure 7. Product Information on Package¹

Table 27. Package Brand Information

Brand Key	Field Description
ADSP-BF70x	Product model
t	Temperature range
рр	Package type
Z	RoHS compliant designation
ccc	See Ordering Guide
vvvvv.x	Assembly lot code
n.n	Silicon revision
yyww	Date code

ABSOLUTE MAXIMUM RATINGS

Stresses at or above those listed in Table 28 may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

Table 28. Absolute Maximum Ratings

Parameter	Rating
Internal Supply Voltage (V _{DD_INT})	-0.33 V to +1.20 V
External (I/O) Supply Voltage (V _{DD_EXT})	-0.33 V to +3.60 V
DDR2 Controller Supply Voltage	-0.33 V to +1.90 V
(V_{DD_DMC})	
USB PHY Supply Voltage (V_{DD_USB})	-0.33 V to +3.60 V
Real-Time Clock Supply Voltage	-0.33 V to +3.60 V
(V_{DD_RTC})	
Housekeeping ADC Supply Voltage	-0.33 V to +3.60 V
(V_{DD_HADC})	
One-Time Programmable Memory	-0.33 V to +3.60 V
Supply Voltage (V _{DD_OTP})	
HADC Reference Voltage (V _{HADC_REF})	-0.33 V to +3.60 V

Table 28. Absolute Maximum Ratings (Continued)

Parameter	Rating
DDR2 Reference Voltage (V _{DDR_REF})	-0.33 V to +1.90 V
Input Voltage ^{1, 2}	-0.33 V to +3.60 V
TWI Input Voltage ^{2, 3}	-0.33 V to +5.50 V
USB0_Dx Input Voltage ⁴	-0.33 V to +5.25 V
USB0_VBUS Input Voltage⁵	-0.33 V to +6 V
DDR2 Input Voltage⁵	-0.33 V to +1.90 V
Output Voltage Swing	$-0.33 \text{ V to V}_{DD_EXT} + 0.5 \text{ V}$
I _{OH} /I _{OL} Current per Signal ¹	4 mA (max)
Storage Temperature Range	-65°C to +150°C
Junction Temperature While Biased	+125°C

¹ Applies to 100% transient duty cycle.

ESD SENSITIVITY



ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

¹ Exact brand may differ, depending on package type.

 $^{^2}$ Applies only when V_{DD_EXT} is within specifications. When V_{DD_EXT} is outside specifications, the range is $V_{DD_EXT}\pm0.2~V.$

³ Applies to balls TWI_SCL and TWI_SDA.

⁴ If the USB is not used, connect USB0_Dx and USB0_VBUS according to Table 15 on Page 38.

 $^{^5}$ Applies only when V_{DD_DMC} is within specifications. When V_{DD_DMC} is outside specifications, the range is $V_{DD_DMC}\pm0.2~V.$

TIMING SPECIFICATIONS

Specifications are subject to change without notice.

Clock and Reset Timing

Table 29 and Figure 8 describe clock and reset operations related to the clock generation unit (CGU). Per the CCLK, SYSCLK, SCLK0, SCLK1, DCLK, and OCLK timing specifications in Table 17 on Page 51 and Table 18 on Page 52, combinations of SYS_CLKIN and clock multipliers must not select clock rates in excess of the processor's maximum instruction rate.

Table 29. Clock and Reset Timing

		1.	V _{DD_EXT} 8 V Nominal	3.3	V _{DD_EXT} 3 V Nominal	
Paramete	r	Min	Max	Min	Max	Unit
Timing Red	quirement					
f_{CKIN}	SYS_CLKIN Crystal Frequency (CGU_CTL.DF = 0) ^{1, 2, 3}	19.2	35	19.2	50	MHz
f_{CKIN}	SYS_CLKIN Crystal Frequency (CGU_CTL.DF = 1) ^{1, 2, 3}	N/A	N/A	38.4	50	MHz
f_{CKIN}	SYS_CLKIN External Source Frequency (CGU_CTL.DF = 0) ^{1, 2, 3}	19.2	60	19.2	60	MHz
f_{CKIN}	SYS_CLKIN External Source Frequency (CGU_CTL.DF = 1) ^{1, 2, 3}	38.4	60	38.4	60	MHz
t_{CKINL}	SYS_CLKIN Low Pulse ¹	8.33		8.33		ns
t _{CKINH}	SYS_CLKIN High Pulse ¹	8.33		8.33		ns
t_{WRST}	SYS_HWRST Asserted Pulse Width Low ⁴	11 × t _{CKII}	N	$11 \times t_{CKIN}$	1	ns

¹ Applies to PLL bypass mode and PLL nonbypass mode.

⁴ Applies after power-up sequence is complete. See Table 30 and Figure 9 for power-up reset timing.

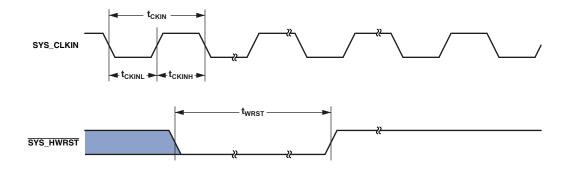


Figure 8. Clock and Reset Timing

 $^{^2}$ The t_{CKIN} period (see Figure 8) equals $1/f_{CKIN}$.

 $^{^3}$ Combinations of the CLKIN frequency and the PLL clock multiplier must not exceed the allowed f_{PLLCLK} setting discussed in Table 19.

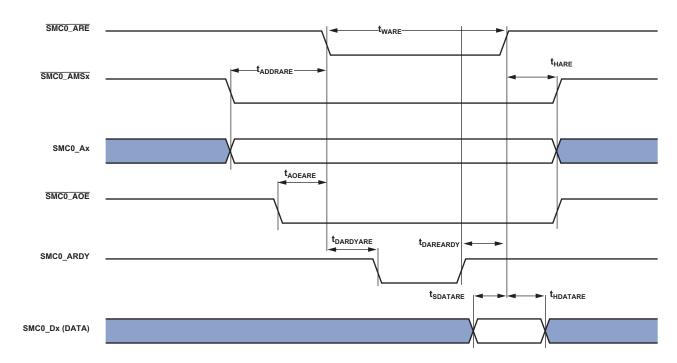


Figure 10. Asynchronous Read

SMC Read Cycle Timing With Reference to SYS_CLKOUT

The following SMC specifications with respect to SYS_CLKOUT are given to accommodate the connection of the SMC to programmable logic devices. These specifications assume that SYS_CLKOUT is outputting a buffered version of SCLK0 by setting CGU_CLKOUTSEL.CLKOUTSEL = 0x3. However, SCLK0 must not run faster than the maximum f_{OCLK} specification. For this example, RST = 0x2, RAT = 0x4, and RHT = 0x1.

Table 32. SMC Read Cycle Timing With Reference to SYS_CLKOUT (BxMODE = b#00)

		1.8	V _{DD_EXT} BV Nominal	3.3	V _{DD_EXT} BV Nominal	
Paramet	er	Min	Max	Min	Max	Unit
Timing Re	equirements					
t_{SDAT}	SMC0_Dx Setup Before SYS_CLKOUT	5.3		4.3		ns
t_{HDAT}	SMC0_Dx Hold After SYS_CLKOUT	1.5		1.5		ns
t _{SARDY}	SMC0_ARDY Setup Before SYS_CLKOUT	16.6		14.4		ns
t_{HARDY}	SMC0_ARDY Hold After SYS_CLKOUT	0.7		0.7		ns
Switching	Characteristics					
t_{DO}	Output Delay After SYS_CLKOUT ¹		7		7	ns
t_{HO}	Output Hold After SYS_CLKOUT 1	-2.5		-2.5		ns

 $^{^1}$ Output signals are SMC0_Ax, $\overline{SMC0_AMSx}, \overline{SMC0_AOE},$ and $\overline{SMC0_ABEx}.$

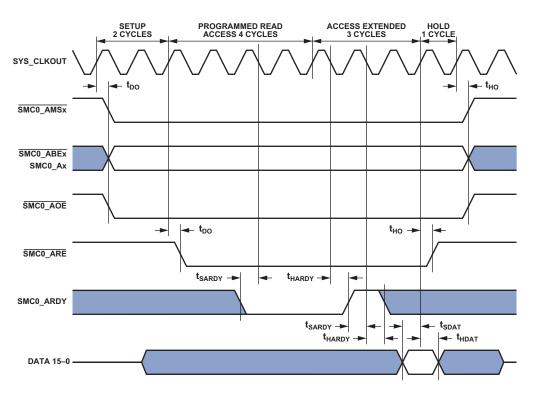


Figure 11. Asynchronous Memory Read Cycle Timing

Asynchronous Page Mode Read

Table 34 and Figure 13 show asynchronous memory page mode read timing, related to the static memory controller (SMC).

Table 34. Asynchronous Page Mode Read

		V _{DD_EXT} 1.8 V /3.3 V Nomina		
Parame	ter	Min	Max	Unit
Switchin	g Characteristics			
t_{AV}	SMC0_Ax (Address) Valid for First Address Min Width ¹	$(PREST + RST + PREAT + RAT) \times t_{SCLK0} - 2$		ns
t _{AV1}	SMC0_Ax (Address) Valid for Subsequent SMC0_Ax (Address) Min Width	PGWS × t _{SCLK0} – 2		ns
t _{WADV}	SMC0_NORDV Active Low Width ²	$RST \times t_{SCLK0} - 2$		ns
t _{HARE}	Output ³ Hold After SMC0_ARE High ⁴	RHT × t _{SCLK0} – 2		ns
t _{WARE} 5	SMC0_ARE Active Low Width ⁶	$(RAT + (Nw - 1) \times PGWS) \times t_{SCLK0} - 2$		ns

¹ PREST, RST, PREAT and RAT values set using the SMC_BxETIM.PREST bits, SMC_BxTIM.RST bits, SMC_BxETIM.PREAT bits, and the SMC_BxTIM.RAT bits.

⁶RAT value set using the SMC_BxTIM.RAT bits.

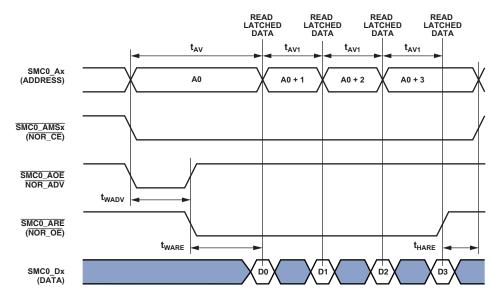


Figure 13. Asynchronous Page Mode Read

²RST value set using the SMC_BxTIM.RST bits.

³ Output signals are SMC0_Ax, SMC0_AMSx, SMC0_AOE.

⁴RHT value set using the SMC_BxTIM.RHT bits.

 $^{^{5}}$ SMC_BxCTL.ARDYEN bit = 0.

Mobile DDR SDRAM Read Cycle Timing

Table 43 and Figure 21 show mobile DDR SDRAM read cycle timing, related to the dynamic memory controller (DMC).

Table 43. Mobile DDR SDRAM Read Cycle Timing, V_{DD_DMC} Nominal 1.8 $\rm V$

			200 MHz	
Parameter		Min	Max	Unit
Timing Requirer	ments			
t_QH	DMC0_DQ, DMC0_DQS Output Hold Time From DMC0_DQS	1.5		ns
t _{DQSQ}	DMC0_DQS-DMC0_DQ Skew for DMC0_DQS and Associated DMC0_DQ Signals		0.7	ns
t _{RPRE}	Read Preamble	0.9	1.1	t _{CK}
t _{RPST}	Read Postamble	0.4	0.6	t _{CK}

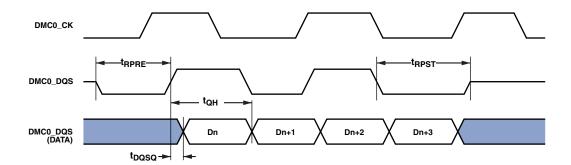
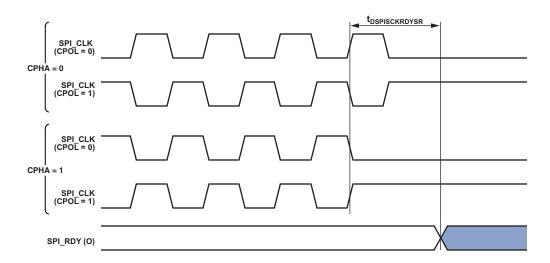


Figure 21. Mobile DDR SDRAM Controller Input AC Timing

Serial Peripheral Interface (SPI) Port—SPI_RDY Slave Timing

Table 56. SPI Port—SPI_RDY Slave Timing

		V _{DD_EXT} 1.8 V/3.3 V Nominal		
Parameter		Min	Max	Unit
Switching C	haracteristics			
t _{DSPISCKRDYSR}	SPI_RDY De-assertion from Valid Input SPI_CLK Edge in Slave Mode Receive	$2.5 \times t_{SCLK0} + t_{HDSPID}$	$3.5 \times t_{SCLK0} + t_{DDSPID}$	ns
t _{DSPISCKRDYST}	SPI_RDY De-assertion from Valid Input SPI_CLK Edge in Slave Mode Transmit	$3.5 \times t_{SCLK0} + t_{HDSPID}$	$4.5 \times t_{SCLK0} + t_{DDSPID}$	ns



 $Figure~33.~~SPI_RDY~De-assertion~from~Valid~Input~SPI_CLK~Edge~in~Slave~Mode~Receive~(FCCH=0)$

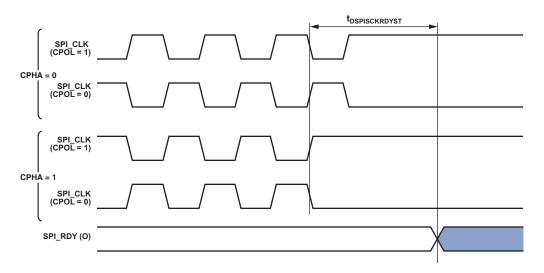


Figure 34. SPI_RDY De-assertion from Valid Input SPI_CLK Edge in Slave Mode Transmit (FCCH = 1)

Serial Peripheral Interface (SPI) Port—SPI_RDY Timing

SPI_RDY is used to provide flow control. The CPOL and CPHA bits are set in SPI_CTL, while LEADX, LAGX, and STOP are in SPI_DLY.

Table 59. SPI Port—SPI_RDY Timing

		V _{DD_EXT} 1.8 V/3.3 V Nominal		
Paramete	er	Min	Max	Unit
Timing Re	quirements			
t _{SRDYSCKM0}	Minimum Setup Time for SPI_RDY De-assertion in Master Mode Before Last SPI_CLK Edge of Valid Data Transfer to Block Subsequent Transfer with CPHA = 0	$(2.5 + 1.5 \times BAUD^{1}) \times t_{SCLK0} + 14.5$		ns
t _{SRDYSCKM1}	Minimum Setup Time for SPI_RDY De-assertion in Master Mode Before Last SPI_CLK Edge of Valid Data Transfer to Block Subsequent Transfer with CPHA = 1	$(2.5 + BAUD^1) \times t_{SCLK0} + 14.5$		ns
Switching	Characteristic			
t _{SRDYSCKM}	Time Between Assertion of SPI_RDY by Slave and First Edge of SPI_CLK for New SPI Transfer with CPHA = 0 and BAUD = 0 (STOP, LEADX, LAGX = 0)	$3 \times t_{SCLK0}$	$4 \times t_{SCLK0} + 17.5$	ns
	Time Between Assertion of SPI_RDY by Slave and First Edge of SPI_CLK for New SPI Transfer with CPHA = 0 and BAUD ≥ 1 (STOP, LEADX, LAGX = 0)	$(4 + 1.5 \times BAUD^1) \times t_{SCLKO}$	$(5 + 1.5 \times BAUD^{1}) \times t_{SCLK0} + 17.5$	ns
	Time Between Assertion of SPI_RDY by Slave and First Edge of SPI_CLK for New SPI Transfer with CPHA = 1 (STOP, LEADX, LAGX = 0)	$(3 + 0.5 \times BAUD^1) \times t_{SCLKO}$	$(4 + 0.5 \times BAUD^{1}) \times t_{SCLK0} + 17.5$	ns

 $^{^{1}\,\}mathrm{BAUD}$ value set using the SPI_CLK.BAUD bits.

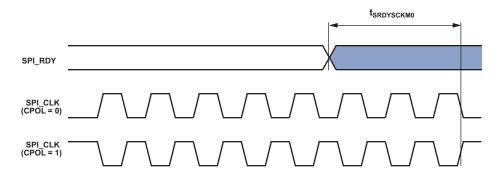


Figure 37. SPI_RDY Setup Before SPI_CLK with CPHA = 0

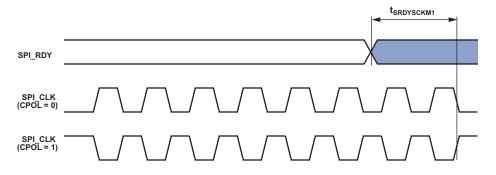


Figure 38. SPI_RDY Setup Before SPI_CLK with CPHA = 1

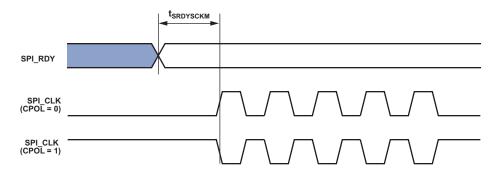


Figure 39. SPI_CLK Switching Diagram after SPI_RDY Assertion, CPHA = x

PLANNED AUTOMOTIVE PRODUCTION PRODUCTS

-			Temperature		Package
Model ^{1, 2, 3}	Max. Core Clock	L2 SRAM	Grade ⁴	Package Description	Option
ADBF702WCCPZ3xx	300 MHz	256K bytes	-40°C to +105°C	88-Lead LFCSP_VQ	CP-88-8
ADBF702WCCPZ4xx	400 MHz	256K bytes	-40°C to +105°C	88-Lead LFCSP_VQ	CP-88-8
ADBF703WCBCZ3xx	300 MHz	256K bytes	-40°C to +105°C	184-Ball CSP_BGA	BC-184-1
ADBF703WCBCZ4xx	400 MHz	256K bytes	-40°C to +105°C	184-Ball CSP_BGA	BC-184-1
ADBF704WCCPZ3xx	300 MHz	512K bytes	-40°C to +105°C	88-Lead LFCSP_VQ	CP-88-8
ADBF704WCCPZ4xx	400 MHz	512K bytes	-40°C to +105°C	88-Lead LFCSP_VQ	CP-88-8
ADBF705WCBCZ3xx	300 MHz	512K bytes	-40°C to +105°C	184-Ball CSP_BGA	BC-184-1
ADBF705WCBCZ4xx	400 MHz	512K bytes	-40°C to +105°C	184-Ball CSP_BGA	BC-184-1
ADBF706WCCPZ3xx	300 MHz	1024K bytes	-40°C to +105°C	88-Lead LFCSP_VQ	CP-88-8
ADBF706WCCPZ4xx	400 MHz	1024K bytes	-40°C to +105°C	88-Lead LFCSP_VQ	CP-88-8
ADBF707WCBCZ3xx	300 MHz	1024K bytes	-40°C to +105°C	184-Ball CSP_BGA	BC-184-1
ADBF707WCBCZ4xx	400 MHz	1024K bytes	-40°C to +105°C	184-Ball CSP_BGA	BC-184-1

 $^{^1}$ Select Automotive grade products, supporting -40°C to $+105^{\circ}\text{C}$ T_{AMBIENT} condition, will be available when they appear in the Automotive Products table. 2 Z = RoHS Compliant Part.

 $^{^3\,\}mathrm{xx}$ denotes the current die revision.

⁴ Referenced temperature is ambient temperature. The ambient temperature is not a specification. See Operating Conditions on Page 50 for the junction temperature (T_J) specification which is the only temperature specification.